

Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

DECLARATION OF COMPLIANCE SAR RF EXPOSURE EVALUATION

Test Lab

CELLTECH LABS INC.

Testing and Engineering Services

1955 Moss Court Kelowna, B.C. Canada V1Y 9L3

Phone: 250-448-7047 Fax: 250-448-7046

e-mail: info@celltechlabs.com web site: www.celltechlabs.com

Applicant Information

PLANTRONICS INC.

345 Encinal Street Santa Cruz, CA 95060

United States

Model(s) Tested: CS55 Base (tested with left side antenna)

CS55 Micro Base (tested with right side antenna)

Serial No.(s) Tested: B79R337395 (CS55 Base)

B79R873729 (CS55 Micro Base)

Rule Part(s): FCC 47 CFR §2.1093; IC RSS-102 Issue 1 (Provisional)

Test Procedure(s): FCC OET Bulletin 65, Supplement C (01-01)
Device Classification: Part 15 Unlicensed PCS Base Station (PUB)
Device Description: Wireless Office Headset System (Base Unit)
Mode of Operation: TDMA (Time Division Multiple Access)

Tx Frequency Range(s): 1921.536 - 1928.448 MHz

RF Output Power Tested: 8.29 dBm (6.75 mW) Peak Conducted (CS55 Base - Left Antenna)

8.46 dBm (7.01 mW) Peak Conducted (CS55 Micro Base - Right Antenna)

Max. Duty Cycle Tested:

8.3 % Source-Based Time-Averaged (Crest Factor: 1:12.05)

Antenna Type(s) Tested:

Internal bent half-dipole over ground plane (Left / Right)

Power Source(s) Tested: 7.5 W Plantronics AC Adapter (P/N: 45561-02)

Max. SAR Level(s) Evaluated: Body: 0.005527 W/kg (Maximum SAR from Area Scan)

Celltech Labs Inc. declares under its sole responsibility that this wireless device is compliant with the Specific Absorption Rate (SAR) RF exposure requirements specified in FCC 47 CFR §2.1093 and Health Canada's Safety Code 6. The device was tested in accordance with the measurement standards and procedures specified in FCC OET Bulletin 65, Supplement C (Edition 01-01), Industry Canada RSS-102 Issue 1 (Provisional) and IEEE Standard 1528-2003 for the General Population / Uncontrolled Exposure environment. All measurements were performed in accordance with the SAR system manufacturer recommendations.

I attest to the accuracy of data. All measurements were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

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Tested By:

Reviewed By:

Sean Johnston Compliance Technologist Celltech Labs Inc. Spencer Watson Senior Compliance Technologist

Spenser Watson

Celltech Labs Inc.





Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	t System - UPCS Base Unit
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz



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Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:		
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1.0 INTRODUCTION

This measurement report demonstrates that the PLANTRONICS Models: CS55 Base / CS55 Micro Base Wireless Office Headset System complies with the SAR (Specific Absorption Rate) RF exposure requirements specified in FCC 47 CFR §2.1093 (see reference [1]) and Health Canada's Safety Code 6 (see reference [2]) for the General Population / Uncontrolled Exposure environment. The test procedures described in FCC OET Bulletin 65, Supplement C, Edition 01-01 (see reference [3]), IC RSS-102 Issue 1 (Provisional) (see reference [4]), and IEEE Standard 1528-2003 (see reference [5]) were employed. A description of the product, operating configuration, detailed summary of the test results, methodology and procedures used in the evaluation, equipment used, and the various provisions of the rules are included within this test report.

2.0 DESCRIPTION OF DEVICE UNDER TEST (DUT)

FCC Rule Part(s)	47 CFR §2.1093						
IC Rule Part(s)	RSS-102 Issue 1 (Provisional)						
FCC Device Classification	Part 15 Unlicensed PCS Base Station (PUB) 15(D)					15(D)	
Test Procedure(s)		FCC OE	T Bulletin 65,	Supplem	ent C (01	-01)	
Device Description		Wireless	Office Heads	et Syster	n (Base l	Unit)	
Model(e) Teeted	CS55 Base	(for long	boom heads	et)	Tested	d with left antenna	
Model(s) Tested	CS55 Micro Ba	se (for s	hort boom he	adset)	Tested	with right antenna	
Serial No.(s) Tested	B79R33739				ntical Prototype		
Serial No.(5) Tested	B79R87372				Identical Prototype		
Tx Frequency Range(s)	1921.536 - 1928.448 MHz UPCS Band				JPCS Band		
Mode(s) of Operation		TDM	A (Time Divisi	sion Multiple Access)			
Maximum Duty Cycle Tested	8.3 %	Sourc	e-Based Time	e-Average	Averaged Crest Factor: 1:12.		
Max. RF Output Power Tested	8.46 dBm Peak C		Conducted	Conducted Right A		CS55 Micro Base	
Max. Kr Output rower resteu	8.29 dBm	Peak	Conducted	Conducted Left Anter		nna CS55 Base	
Power Source(s) Tested	7.5 W Plantr	onics A0	Adapter		Part No.	rt No.: 45561-02	
Antenna Type(s) Tested	Interna		Bent half-o	dipole ove	er ground	plane (Left / Right)	
	Left Sid	е	0.0 cm	0.0 cm spacing		CS55 Base	
	Front Left Side	e Tilted	0.0 cm	spacing		CS55 Base	
	Right Sid	de	0.0 cm	spacing	(CS55 Micro Base	
DUT Configurations Evaluated	Front Right Sic	le Tilted	0.0 cm	spacing	(CS55 Micro Base	
	Note: The 1g averaged SAR was not measured because the peak SAR values from the area scan evaluations for each test configuration was less than 1% of 1.6 W/kg (1g average limit). The peak SAR values measured during the area scan evaluations for each test configuration are reported.						

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz		
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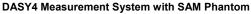


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3.0 SAR MEASUREMENT SYSTEM

Celltech Labs Inc. SAR measurement facility utilizes the Dosimetric Assessment System (DASY™) manufactured by Schmid & Partner Engineering AG (SPEAG™) of Zurich, Switzerland. The DASY4 measurement system is comprised of the measurement server, robot controller, computer, near-field probe, probe alignment sensor, specific anthropomorphic mannequin (SAM) phantom, and various planar phantoms for brain and/or body SAR evaluations. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF). A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The Staubli robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electrooptical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the DASY4 measurement server. The DAE4 utilizes a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16-bit AD-converter and a command decoder and control logic unit. Transmission to the DASY4 measurement server is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe-mounting device includes two different sensor systems for frontal and sidewise probe contacts. The sensor systems are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.







DASY4 Measurement System with SAM Phantom

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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4.0 MEASUREMENT SUMMARY

Freq. (MHz)	Chan	Power Source	D	UT Model	Ant	tenna	DUT Position to Planar	Separation Distance to Planar Phantom	Max. Cond. Power	SAR Area	imum I from		
						Туре	Position	Phantom	(cm)	(dBm)	(VV	//kg)	
1924.992	3	TDMA	AC Adapter	CS5	5 Micro Base	Internal	Right Side	Right Side	0.0	8.46	0.00)5527	
1924.992	3	TDMA	AC Adapter	CS5	5 Micro Base	Internal	Right Side	Front Side Right Tilted	0.0	0.0 8.46		0.002693	
1924.992	3	TDMA	AC Adapter	С	S55 Base	Internal	Left Side	Left Side	0.0	8.29	0.00)4225	
1924.992	3	TDMA	AC Adapter	С	S55 Base	Internal	Left Side	Front Side Left Tilted	0.0	0.0 8.29		0.001607	
			Spatia	BOL	SI / IEEE C95 DY: 1.6 W/kg - Uncontrolle	(averaged	l over 1 gra						
	Test Date	e(s)		F	Aug 2, 2005		Rela	tive Humidity		36		%	
Mea	sured Flu	id Type		192	25 MHz Body		Atmos	oheric Pressur	е	102.2		kPa	
Die	lectric Co	nstant	IEEE 1	arget	Measured	Deviation	Ambie	nt Temperature	е	23.4		°C	
	ε _r	53.3 ±		± 5%	51.5	-3.4%	Fluid	Fluid Temperature		22.5		°C	
	Conducti	vity	IEEE 1	arget	arget Measured Deviation		FI	Fluid Depth		≥ 15		cm	
σ (mho/m)		1.52	± 5%	1.54	+1.3% ρ (Kg /m³)				1000				

Note(s):

- 1. The measurement results were obtained with the DUT tested in the conditions described in this report. Detailed measurement data and plots showing the maximum SAR location of the DUT are reported in Appendix A.
- The 1g averaged SAR was not measured because the peak SAR values from the area scan evaluations for each test configuration was less than 1% of 1.6 mW/g (1g average limit). The peak SAR values measured during the area scan evaluations for each test configuration are reported.
- 3. The transmission band of the DUT is less than 10 MHz; therefore mid channel data only is reported (per FCC OET Bulletin 65, Supplement C, Edition 01-01 see reference [3]).
- 4. The ambient and fluid temperatures were measured prior to, and during, the fluid dielectric parameter check and the SAR evaluations. The temperatures reported were consistent for all measurement periods.
- The dielectric parameters of the simulated tissue mixture were measured prior to the SAR evaluations using an ALS-PR-DIEL Dielectric Probe Kit and an HP 8753ET Network Analyzer (see Appendix E for measured fluid dielectric parameters).
- The SAR measurements were performed within 24 hours of the system performance check.

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.		
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz			
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5.0 DETAILS OF SAR EVALUATION

The PLANTRONICS Models: CS55 Base / CS55 Micro Base Wireless Office Headset System was compliant for localized Specific Absorption Rate (SAR) based on the test provisions and conditions described below. The detailed test setup photographs are shown in Appendix D.

- 1) The DUT was tested for body SAR with the right side of the DUT (right side antenna) facing parallel to, and touching, the outer surface of the SAM phantom (planar section).
- 2) The DUT was tested for body SAR with the front right side of the DUT (right side antenna) tilted, facing parallel to, and touching, the outer surface of the SAM phantom (planar section).
- 3) The DUT was tested for body SAR with the left side of the DUT (left side antenna) facing parallel to, and touching, the outer surface of the SAM phantom (planar section).
- 4) The DUT was tested for body SAR with the front left side of the DUT (left side antenna) tilted, facing parallel to, and touching, the outer surface of the SAM phantom (planar section).
- 5) The base unit was placed 1-meter away from the headset unit. After a 10 second period the link contact switch on the headset unit was depressed. The green LED on the front face of the base unit is illuminated and the base unit clicks as the relays close. The green LED on the headset unit then begins to flash to indicate the device is now in test mode.
- 6) The DUT was tested at the max. power setting in TDMA mode with a duty cycle of 8.3% (crest factor = 1:12.05).
- 7) The conducted power level(s) of the DUT were measured prior to the SAR evaluations using a Rohde & Schwarz CMD60 digital radiocommunication tester according to the measurement procedures described in FCC 47 CFR \$2 1046
- 8) The DUT was tested with the AC power adapter.
- 9) The ambient and fluid temperatures were measured prior to, and during, the fluid dielectric parameter check and the SAR evaluations. The temperatures reported were consistent for all measurement periods.
- 10) The dielectric parameters of the simulated tissue mixture were measured prior to the SAR evaluations using an ALS-PR-DIEL Dielectric Probe Kit and an HP 8753ET Network Analyzer (see Appendix E for measured fluid dielectric parameters).
- 11) The SAR measurements were performed within 24 hours of the system performance check.
- 12) The 1g averaged SAR was not measured because the peak SAR value from the area scan evaluations for each test configuration was less than 1% of 1.6 mW/g (1g average limit). The peak SAR values measured during the area scan evaluations for each test configuration are reported.

6.0 EVALUATION PROCEDURES

- a. (i) The evaluation was performed in the applicable area of the phantom depending on the type of device being tested. For devices held to the ear during normal operation, both the left and right ear positions were evaluated using the SAM phantom.
 - (ii) For body-worn and face-held devices a planar phantom was used.
- b. The SAR was determined by a pre-defined procedure within the DASY4 software. Upon completion of a reference and optical surface check, the exposed region of the phantom was scanned near the inner surface with a grid spacing of 15mm x 15mm.
 - An area scan was determined as follows:
- c. Based on the defined area scan grid, a more detailed grid is created to increase the points by a factor of 10. The interpolation function then evaluates all field values between corresponding measurement points.
- d. A linear search is applied to find all the candidate maxima. Subsequently, all maxima are removed that are >2 dB from the global maximum. The remaining maxima are then used to position the cube scans.
 - A 1g and 10g spatial peak SAR was determined as follows:
- e. Extrapolation is used to find the points between the dipole center of the probe and the surface of the phantom. This data cannot be measured, since the center of the dipoles is 2.7 mm away from the tip of the probe and the distance between the surface and the lowest measuring point is 1.4 mm (see probe calibration document in Appendix F). The extrapolation was based on trivariate quadratics computed from the previously calculated 3D interpolated points nearest the phantom surface.
- f. Interpolated data is used to calculate the average SAR over 1g and 10g cubes by spatially discretizing the entire measured cube. The volume used to determine the averaged SAR is a 1mm grid (42875 interpolated points).
- g. A zoom scan volume of 32 mm x 32 mm x 30 mm (5x5x7 points) centered at the peak SAR location determined from the area scan is used for all zoom scans for devices with a transmit frequency < 800 MHz. Zoom scans for frequencies ≥ 800 MHz are determined with a scan volume of 30 mm x 30 mm x 30 mm (7x7x7 points) to ensure complete capture of the peak spatial-average SAR.

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Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz		
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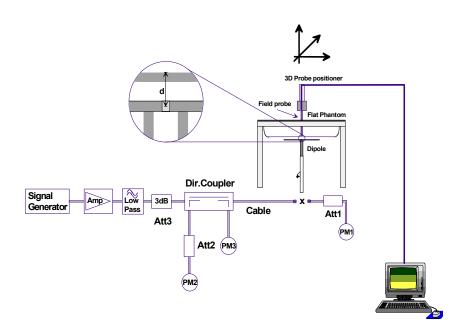
7.0 SYSTEM PERFORMANCE CHECK

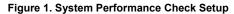
Prior to the SAR evaluation a system check was performed at the planar section of the SAM phantom with a 1900MHz dipole (see Appendix E for system validation procedures). The dielectric parameters of the simulated tissue mixture were measured prior to the system performance check using an ALS-PR-DIEL Dielectric Probe Kit and an HP 8753ET Network Analyzer (see Appendix C for measured fluid dielectric parameters). A forward power of 250 mW was applied to the dipole and the system was verified to a tolerance of +10% (see Appendix B for system performance check test plot).

	SYSTEM PERFORMANCE CHECK															
Test	1900MHz Equiv.		SAR 1g (W/kg)		Dielect	ric Const ε _r	ant		Conductivity σ (mho/m)		ρ Amb.	Amb. Temp.		Fluid Depth	Humid.	Barom. Press.
Date	Tissue	IEEE Target	Meas.	Dev.	IEEE Target	Meas.	Dev.	IEEE Target	Meas.	Dev.	(Kg/m³)	(°C)	(°C)	(cm)	(%)	(kPa)
8/2/05	Brain	9.93 ±10%	10.9	+9.8%	40.0 ±5%	38.2	-4.5%	1.40 ±5%	1.43	+2.1%	1000	24.6	23.3	≥ 15	30	102.2

Note(s):

^{1.} The ambient and fluid temperatures were measured prior to, and during, the fluid dielectric parameter check and the system performance check. The temperatures listed in the table above were consistent for all measurement periods.







1900MHz Dipole Setup

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。		
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz		
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8.0 SIMULATED EQUIVALENT TISSUES

The 1900/1925MHz brain and body simulated equivalent tissue mixtures consist of Glycol-monobutyl, water, and salt. The fluids were prepared according to standardized procedures and measured for dielectric parameters (permittivity and conductivity).

1900/1925 MHz SIMULATED TISSUE MIXTURES									
INGREDIENT	1900 MHz Brain	1925 MHz Body							
INGREDIENT	System Performance Check	DUT Evaluation							
Water	55.85 %	69.85 %							
Glycol Monobutyl	44.00 %	29.89 %							
Salt	0.15 %	0.26 %							

9.0 SAR SAFETY LIMITS

EXPOSURE LIMITS	SAR (W/kg)			
EXPOSURE LIMITS	(General Population / Uncontrolled Exposure Environment)	(Occupational / Controlled Exposure Environment)		
Spatial Average (averaged over the whole body)	0.08	0.4		
Spatial Peak (averaged over any 1 g of tissue)	1.60	8.0		
Spatial Peak (hands/wrists/feet/ankles averaged over 10 g)	4.0	20.0		

Notes:

- 1. Uncontrolled environments are defined as locations where there is potential exposure of individuals who have no knowledge or control of their potential exposure.
- 2. Controlled environments are defined as locations where there is potential exposure of individuals who have knowledge of their potential exposure and can exercise control over their exposure.

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。	
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10.0 ROBOT SYSTEM SPECIFICATIONS

Specifications

POSITIONER: Stäubli Unimation Corp. Robot Model: RX60L

Repeatability: 0.02 mm

No. of axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller

Processor: AMD Athlon XP 2400+

Clock Speed: 2.0 GHz

Operating System: Windows XP Professional

Data Converter

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY4 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock

DASY4 Measurement Server

Function: Real-time data evaluation for field measurements and surface detection

Hardware: PC/104 166MHz Pentium CPU; 32 MB chipdisk; 64 MB RAM **Connections:** COM1, COM2, DAE, Robot, Ethernet, Service Interface

E-Field Probe

Model: ET3DV6 Serial No.: 1387

Construction: Triangular core fiber optic detection system

Frequency: 10 MHz to 6 GHz

Linearity: $\pm 0.2 \text{ dB} (30 \text{ MHz to } 3 \text{ GHz})$

Phantom(s)

Type:SAM V4.0CShell Material:FiberglassThickness: $2.0 \pm 0.1 \text{ mm}$ Volume:Approx. 25 liters



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11.0 PROBE SPECIFICATION (ET3DV6)

Construction: Symmetrical design with triangular core

Built-in shielding against static charges

PEEK enclosure material (resistant to organic solvents,

e.g. glycol)

Calibration: In air from 10 MHz to 2.5 GHz

In brain simulating tissue at frequencies of 900 MHz

and 1.8 GHz (accuracy ± 8%)

Frequency: 10 MHz to >6 GHz; Linearity: ±0.2 dB

(30 MHz to 3 GHz)

Directivity: ± 0.2 dB in brain tissue (rotation around probe axis)

 ± 0.4 dB in brain tissue (rotation normal to probe axis)

Dynamic Range: 5 μ W/g to >100 mW/g; Linearity: \pm 0.2 dB

Surface Detection: ± 0.2 mm repeatability in air and clear liquids over

diffuse reflecting surfaces

Dimensions: Overall length: 330 mm

Tip length: 16 mm Body diameter: 12 mm Tip diameter: 6.8 mm

Distance from probe tip to dipole centers: 2.7 mm

Application: General dosimetry up to 3 GHz

Compliance tests of mobile phone



ET3DV6 E-Field Probe

12.0 SAM PHANTOM V4.0C

The SAM phantom V4.0C is a fiberglass shell phantom with a 2.0 mm (+/-0.2 mm) shell thickness for left and right head and flat planar area integrated in a wooden table. The shape of the fiberglass shell corresponds to the phantom defined by SCC34-SC2. The device holder positions are adjusted to the standard measurement positions in the three sections (see Appendix G for specifications of the SAM phantom V4.0C).



SAM Phantom V4.0C

13.0 DEVICE HOLDER

The DASY4 device holder has two scales for device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear openings). The plane between the ear openings and the mouth tip has a rotation angle of 65°. The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. For evaluations of larger devices such as Laptop and Tablet PCs, a Plexiglas platform is attached to the device holder.



Device Holder

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14.0 TEST EQUIPMENT LIST

	TEST EQUIPMENT		055141.410		DATE	CALIBRATION
USED	DESCRIPTION	ASSET NO.	SERIAL NO.		IBRATED	DUE DATE
х	Schmid & Partner DASY4 System	-	-		-	-
х	-DASY4 Measurement Server	00158	1078		N/A	N/A
х	-Robot	00046	599396-01	N/A		N/A
	-DAE4	00019	353	1	5Jun05	15Jun06
х	-DAE3	00018	370	2	5Jan05	25Jan06
х	-ET3DV6 E-Field Probe	00016	1387	1	8Mar05	18Mar06
	-ET3DV6 E-Field Probe	00017	1590	2	0May05	20May06
	-EX3DV4 E-Field Probe	00125	3547	2	1Jan05	21Jan06
	-300MHz Validation Dipole	00023	135	2	6Oct04	26Oct05
	-450MHz Validation Dipole	00024	136	0-	4Nov04	04Nov05
	OOFMULE Validation Dinale	00000	444	Brain	30Mar05	30Mar06
	-835MHz Validation Dipole	00022	411	Body	12Apr05	12Apr06
	COOM In Validation Dinals	00000	054	Brain	10Jun05	10Jun06
	-900MHz Validation Dipole	00020	054	Body	10Jun05	10Jun06
	1900MUE Validation Dinale	00024	247	Brain	14Jun05	14Jun06
	-1800MHz Validation Dipole	00021	247	Body	14Jun05	14Jun06
х	1000MUz Validation Dinala	00033	151	Brain	17Jun05	17Jun06
	-1900MHz Validation Dipole	00032	151	Body	22Apr05	22Apr06
	24F0MH- Validation Dinala	00005	450	Brain	30Sep04	30Sep05
	-2450MHz Validation Dipole	00025	150	Body	22Apr05	22Apr06
	FOOOM In Validation Dinals	00400	4004	Brain	11Jan05	11Jan06
	-5000MHz Validation Dipole	00126	1031	Body	11Jan05	11Jan06
х	-SAM Phantom V4.0C	00154	1033		N/A	N/A
	-Barski Planar Phantom	00155	03-01		N/A	N/A
	-Plexiglas Planar Phantom	00156	161		N/A	N/A
	-Validation Planar Phantom	00157	137		N/A	N/A
	HP 85070C Dielectric Probe Kit	00033	N/A		N/A	N/A
х	ALS-PR-DIEL Dielectric Probe Kit	00160	260-00953		N/A	N/A
Х	Gigatronics 8652A Power Meter	00110	1835801	1	6Apr05	16Apr06
	Gigatronics 8652A Power Meter	80000	1835267	2	9Apr05	29Apr06
	Gigatronics 8652A Power Meter	00007	1835272	1	8Oct04	18Oct05
х	Gigatronics 80701A Power Sensor	00011	1833542	0	8Oct04	08Oct05
Х	Gigatronics 80701A Power Sensor	00109	1834366	1	6Apr05	16Apr06
х	HP 8753ET Network Analyzer	00134	US39170292	04	4May05	04May06
Х	HP 8648D Signal Generator	00005	3847A00611	2	9Apr05	29Apr06
х	Rohde & Schwarz CMD60 Test Set	na	843478/014	2	0Sep04	20Sep05
х	Rohde & Schwarz CMD60 Test Set	na	846026/008	0	7Mar05	06Mar06
Х	Amplifier Research 5S1G4 Power Amplifier	00106	26235		N/A	N/A

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。		
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:			
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

15.0 MEASUREMENT UNCERTAINTIES

UNCERTAINTY BUDGET FOR DEVICE EVALUATION								
Error Description	Uncertainty Value ±%	Probability Distribution	Divisor	ci 1g	Uncertainty Value ±% (1g)	V _i or V _{eff}		
Measurement System								
Probe calibration	5.5	Normal	1	1	5.5	∞		
Axial isotropy of the probe	4.7	Rectangular	1.732050808	0.7	1.9	∞		
Spherical isotropy of the probe	9.6	Rectangular	1.732050808	0.7	3.9	∞		
Spatial resolution	0	Rectangular	1.732050808	1	0.0	8		
Boundary effects	1	Rectangular	1.732050808	1	0.6	∞		
Probe linearity	4.7	Rectangular	1.732050808	1	2.7	∞		
Detection limit	1	Rectangular	1.732050808	1	0.6	∞		
Readout electronics	0.3	Normal	1	1	0.3	∞		
Response time	0.8	Rectangular	1.732050808	1	0.5	∞		
Integration time	2.6	Rectangular	1.732050808	1	1.5	∞		
RF ambient conditions	3	Rectangular	1.732050808	1	1.7	∞		
Mech. constraints of robot	0.4	Rectangular	1.732050808	1	0.2	∞		
Probe positioning	2.9	Rectangular	1.732050808	1	1.7	∞		
Extrapolation & integration	1	Rectangular	1.732050808	1	0.6	∞		
Test Sample Related								
Device positioning	2.9	Normal	1	1	2.9	12		
Device holder uncertainty	3.6	Normal	1	1	3.6	8		
Power drift	5	Rectangular	1.732050808	1	2.9	8		
Phantom and Setup								
Phantom uncertainty	4	Rectangular	1.732050808	1	2.3	∞		
Liquid conductivity (target)	5	Rectangular	1.732050808	0.64	1.8	8		
Liquid conductivity (measured)	2.5	Normal	1	0.64	1.6	8		
Liquid permittivity (target)	5	Rectangular	1.732050808	0.6	1.7	8		
Liquid permittivity (measured)	2.5	Normal	1	0.6	1.5	8		
Combined Standard Uncertaint	.y				10.58			
Expanded Uncertainty (k=2)					21.16			

Measurement Uncertainty Table in accordance with IEEE Standard 1528-2003 (see reference [5])

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz		
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

MEASUREMENT UNCERTAINTIES (CONT.)

UNCERTAINTY BUDGET FOR SYSTEM VALIDATION								
Error Description	Uncertainty Value ±%	Probability Distribution	Divisor	ci 1g	Uncertainty Value ±% (1g)	V _i or V _{eff}		
Measurement System								
Probe calibration	5.5	Normal	1	1	5.5	∞		
Axial isotropy of the probe	4.7	Rectangular	1.732050808	1	2.7	∞		
Spherical isotropy of the probe	0	Rectangular	1.732050808	1	0.0	∞		
Spatial resolution	0	Rectangular	1.732050808	1	0.0	∞		
Boundary effects	1	Rectangular	1.732050808	1	0.6	∞		
Probe linearity	4.7	Rectangular	1.732050808	1	2.7	∞		
Detection limit	1	Rectangular	1.732050808	1	0.6	∞		
Readout electronics	0.3	Normal	1	1	0.3	∞		
Response time	0	Rectangular	1.732050808	1	0.0	∞		
Integration time	0	Rectangular	1.732050808	1	0.0	∞		
RF ambient conditions	3	Rectangular	1.732050808	1	1.7	∞		
Mech. constraints of robot	0.4	Rectangular	1.732050808	1	0.2	∞		
Probe positioning	2.9	Rectangular	1.732050808	1	1.7	∞		
Extrapolation & integration	1	Rectangular	1.732050808	1	0.6	∞		
Test Sample Related								
Dipole Positioning	2	Normal	1.732050808	1	1.2	∞		
Power & Power Drift	4.7	Normal	1.732050808	1	2.7	∞		
Phantom and Setup								
Phantom uncertainty	4	Rectangular	1.732050808	1	2.3	∞		
Liquid conductivity (target)	5	Rectangular	1.732050808	0.64	1.8	∞		
Liquid conductivity (measured)	2.5	Normal	1	0.64	1.6	∞		
Liquid permittivity (target)	5	Rectangular	1.732050808	0.6	1.7	∞		
Liquid permittivity (measured)	2.5	Normal	1	0.6	1.5	∞		
Combined Standard Uncertainty	v				8.79			
Expanded Uncertainty (k=2)					17.57			

Measurement Uncertainty Table in accordance with IEEE Standard 1528-2003 (see reference [5])

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:		
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

16.0 REFERENCES

- [1] Federal Communications Commission, "Radiofrequency radiation exposure evaluation: portable devices", Rule Part 47 CFR §2.1093: 1999.
- [2] Health Canada, "Limits of Human Exposure to Radiofrequency Electromagnetic Fields in the Frequency Range from 3 kHz to 300 GHz", Safety Code 6.
- [3] Federal Communications Commission, "Evaluating Compliance with FCC Guidelines for Human Exposure to Radio frequency Electromagnetic Fields", OET Bulletin 65, Supplement C (Edition 01-01), FCC, Washington, D.C.: June 2001.
- [4] Industry Canada, "Evaluation Procedure for Mobile and Portable Radio Transmitters with respect to Health Canada's Safety Code 6 for Exposure of Humans to Radio Frequency Fields", Radio Standards Specification RSS-102 Issue 1 (Provisional): September 1999.
- [5] IEEE Standard 1528-2003, "Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques": December 2003.

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.		
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:			
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

APPENDIX A - SAR MEASUREMENT DATA

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448		
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

Body SAR - Right Side of DUT - Right Side Internal Antenna - CS55 Micro Base

DUT: Plantronics Inc. Model: CS55 Micro Base; Type: Wireless Office Headset System; Serial: B79R873729

Ambient Temp: 23.4 °C; Fluid Temp: 22.5 °C; Barometric Pressure: 102.2 kPa; Humidity: 36%

Communication System: TDMA

7.5 W AC Power Ádapter (P/N: 45561-02) RF Output Power: 8.46 dBm (Peak Conducted)

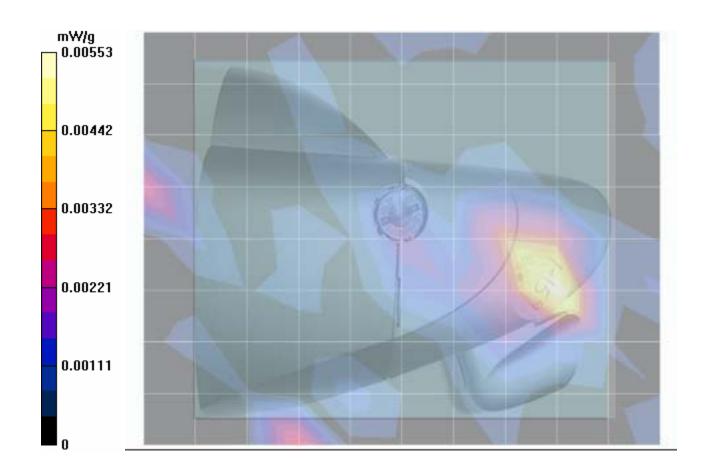
Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05 Medium: M1925 (σ = 1.54 mho/m; ϵ_r = 51.5; ρ = 1000 kg/m³)

- Probe: ET3DV6 SN1387; ConvF(4.6, 4.6, 4.6); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

Body SAR - 0.0 cm Separation Distance from Right Side of DUT to Planar Phantom/Area Scan (9x11x1):

Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (measured) = 0.005527 mW/g



ĺ	Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
ĺ	Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz		
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

Body SAR - Front Side of DUT (Right Side Tilted) - Right Side Internal Antenna - CS55 Micro Base

DUT: Plantronics Inc. Model: CS55 Micro Base; Type: Wireless Office Headset System; Serial: B79R873729

Ambient Temp: 23.4 °C; Fluid Temp: 22.5 °C; Barometric Pressure: 102.2 kPa; Humidity: 36%

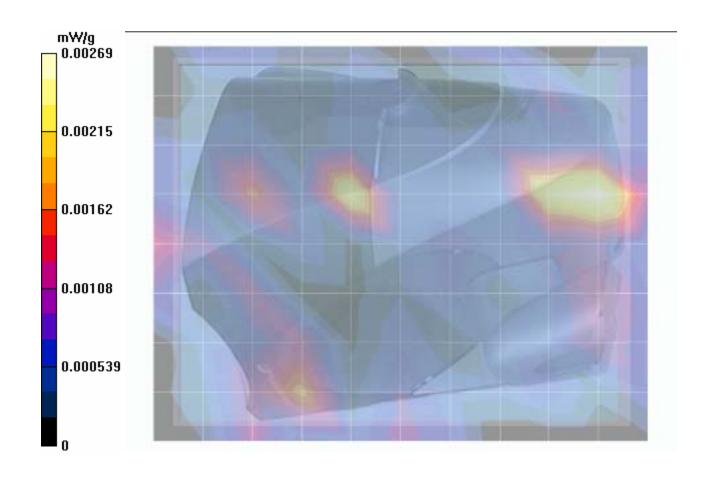
Communication System: TDMA

7.5 W AC Power Adapter (P/N: 45561-02) RF Output Power: 8.46 dBm (Peak Conducted)

Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05 Medium: M1925 (σ = 1.54 mho/m; ϵ_r = 51.5; ρ = 1000 kg/m³)

- Probe: ET3DV6 SN1387; ConvF(4.6, 4.6, 4.6); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

Body SAR - 0.0 cm Separation Distance from Front Side of DUT (Right Side Tilted) to Planar Phantom Area Scan (9x11x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.002693 mW/g



Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

Body SAR - Left Side of DUT - Left Side Internal Antenna - CS55 Base

DUT: Plantronics Inc. Model: CS55 Base; Type: Wireless Office Headset System; Serial: B79R337395

Ambient Temp: 23.4 °C; Fluid Temp: 22.5 °C; Barometric Pressure: 102.2 kPa; Humidity: 36%

Communication System: TDMA

7.5 W AC Power Ádapter (P/N: 45561-02) RF Output Power: 8.29 dBm (Peak Conducted)

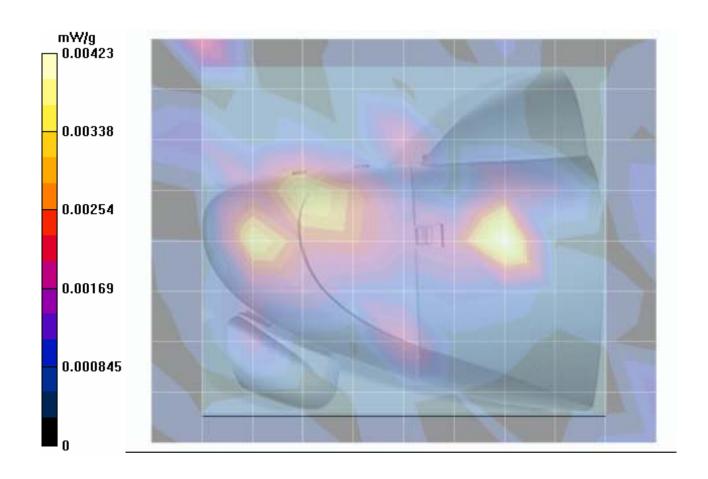
Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05 Medium: M1925 (σ = 1.54 mho/m; ϵ_r = 51.5; ρ = 1000 kg/m³)

- Probe: ET3DV6 SN1387; ConvF(4.6, 4.6, 4.6); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005 - Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

Body SAR - 0.0 cm Separation Distance from Left Side of DUT to Planar Phantom/Area Scan (9x11x1):

Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (measured) = 0.004225 mW/g



	Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。	
	Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

Body SAR - Front Side of DUT (Left Side Tilted) - Left Side Internal Antenna - CS55 Base

DUT: Plantronics Inc. Model: CS55 Base; Type: Wireless Office Headset System; Serial: B79R337395

Ambient Temp: 23.4 °C; Fluid Temp: 22.5 °C; Barometric Pressure: 102.2 kPa; Humidity: 36%

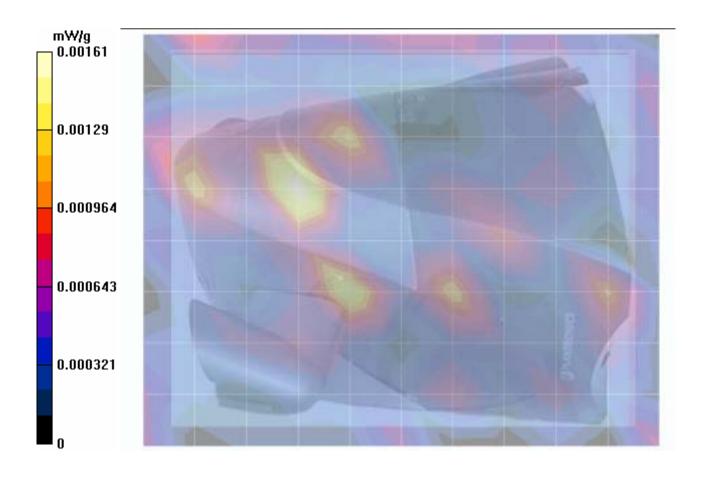
Communication System: TDMA

7.5 W AC Power Ádapter (P/N: 45561-02) RF Output Power: 8.29 dBm (Peak Conducted)

Frequency: 1924.992 MHz; Channel 3; Duty Cycle: 1:12.05 Medium: M1925 (σ = 1.54 mho/m; ϵ_r = 51.5; ρ = 1000 kg/m³)

- Probe: ET3DV6 SN1387; ConvF(4.6, 4.6, 4.6); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 93

Body SAR - 0.0 cm Separation Distance from Front Side of DUT (Left Side Tilted) to Planar Phantom Area Scan (9x11x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.001607 mW/g



Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	t System - UPCS Base Unit	■ PLANTRONICS。
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

Fluid Depth (>15cm)



Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		■ PLANTRONICS。
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

APPENDIX B - SYSTEM PERFORMANCE CHECK DATA

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

System Performance Check (Brain) - 1900 MHz Dipole

DUT: Dipole 1900 MHz; Model: D1900V2; Type: System Performance Check; Serial: 151; Calibrated: 06/17/2005

Ambient Temp: 24.6 °C; Fluid Temp: 23.3 °C; Barometric Pressure: 102.2 kPa; Humidity: 30%

Communication System: CW

Forward Conducted Power: 250 mW Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL1900 (σ = 1.43 mho/m; ε_r = 38.2; ρ = 1000 kg/m³)

- Probe: ET3DV6 SN1387; ConvF(5.18, 5.18, 5.18); Calibrated: 18/03/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

1900 MHz Dipole - System Performance Check/Area Scan (5x8x1):

Measurement grid: dx=15mm, dy=15mm

1900 MHz Dipole - System Performance Check/Zoom Scan (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 98.2 V/m; Power Drift = -0.039 dB

Peak SAR (extrapolated) = 19.6 W/kg

SAR(1 g) = 10.9 mW/g; SAR(10 g) = 5.64 mW/g

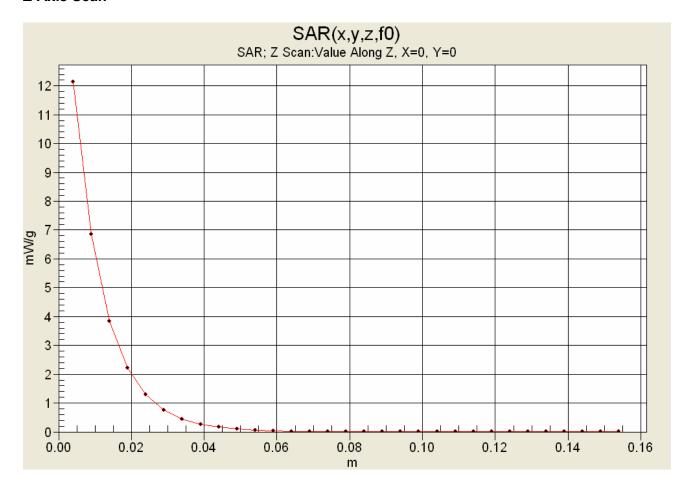


Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

Z-Axis Scan



Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz		
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Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

APPENDIX C - MEASURED FLUID DIELECTRIC PARAMETERS

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55 Micro Base Tx Frequen		Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

1925 MHz DUT Evaluation (Body) Celltech Labs Inc. Test Result for UIM Dielectric Parameter Tue 02/Aug/2005 Freq Frequency (GHz) FCC_eH FCC Bulletin 65 Supplement C (June 2001) Limits for Head Epsilon FCC_sH FCC Bulletin 65 Supplement C (June 2001) Limits for Head Sigma FCC_eB FCC Limits for Body Epsilon FCC_sB FCC Limits for Body Sigma Test e Epsilon of UIM Test_s Sigma of UIM ***************** FCC_eB FCC_sB Test_e Test_s Freq 53.30 1.52 51.89 1.8250 1.44 1.8350 53.30 1.52 51.74 1.44 1.8450 53.30 1.52 51.70 1.46 1.8550 53.30 1.52 51.58 1.47 1.52 51.73 1.8650 53.30 1.48 51.54 1.48 1.8750 53.30 1.52 1.8850 53.30 1.52 51.67 1.49 53.30 1.52 51.57 1.50 1.8950 53.30 1.52 51.58 1.9050 1.52 1.52 51.57 1.9150 53.30 1.53 (1.9250) 53.30 1.52 51.46 (1.54) 53.30 1.52 51.45 1.55 1.9350 1.9450 53.30 1.52 51.47 1.55 1.9550 53.30 1.52 51.51 1.56 53.30 1.52 51.43 1.9650 1.58 1.52 51.51 1.9750 53.30 1.59 51.47 1.60 1.9850 53.30 1.52 1.9950 53.30 1.52 51.41 1.62 2.0050 53.29 1.52 51.47 1.63 53.28 1.53 51.47 1.64 2.0150 53.27 1.54 51.37 2.0250 1.64

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Report Issue No.:		Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

1900 MHz System Performance Check (Brain)

Celltech Labs Inc.

Test Result for UIM Dielectric Parameter

Tue 02/Aug/2005

Freq Frequency(GHz)

FCC_eH FCC OET 65 Supplement C (June 2001) Limits for Head Epsilon FCC_sH FCC OET 65 Supplement C (June 2001) Limits for Head Sigma

Test_e Epsilon of UIM

Test_s Sigma of UIM

*********	*****	*****	*****	*****	********
Freq	FCC_eH	FCC_sH	Test_e	Test_s	

rreq	rcc_en	FCC_SH	Test_e	rest_
1.8000 1.8100	40.00	1.40	38.26	1.35
1.8100	40.00	1.40	38.02	1.36
1.8200	40.00	1.40	38.22	1.37
1.8300	40.00	1.40	38.12	1.39
1.8400	40.00	1.40	37.90	1.40
1.8500	40.00	1.40	38.20	1.40
1.8600	40.00	1.40	38.03	1.41
1.8700	40.00	1.40	38.11	1.44
1.8800	40.00	1.40	38.06	1.42
1.8900	40.00	1.40	37.91	1.44
1.9000	40.00	1.40	38.15	(1.43)
	40.00			
1.9200	40.00	1.40	37.97	1.46
	40.00			
1.9400	40.00	1.40	37.68	1.51
1.9500	40.00	1.40	37.90	1.50
1.9600	40.00	1.40	37.79	1.51
1.9700	40.00	1.40	37.57	1.51
	40.00			
1.9900	40.00	1.40	37.69	1.54
2.0000	40.00	1.40	37.66	1.54

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz		
2005 Celltech Lal	Labs Inc. 26 of 39				



Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

APPENDIX D - SAR TEST SETUP & DUT PHOTOGRAPHS

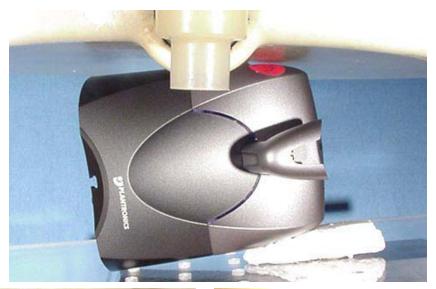
Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55 Micro Base		Tx Frequency Range:	1921.536 - 1928.448 MHz	
2005 Celltech Lab	Labs Inc. 27 of 39				



Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

BODY SAR TEST SETUP PHOTOGRAPHS

CS55 Micro Base - Right Side of DUT (Right Side Internal Antenna) - Touch Position









Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	CS55 Base, CS55 Micro Base T		1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

BODY SAR TEST SETUP PHOTOGRAPHS
CS55 Micro Base - Front Side of DUT (Right Side Tilted - Right Side Internal Antenna) - Touch Position









Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		PLANTRONICS.
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure SAR I		FCC 2.1093	IC RSS-102

BODY SAR TEST SETUP PHOTOGRAPHS

CS55 Base - Left Side of DUT (Left Side Internal Antenna) - Touch Position









Applic	ant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	■ PLANTRONICS。	
Mode	(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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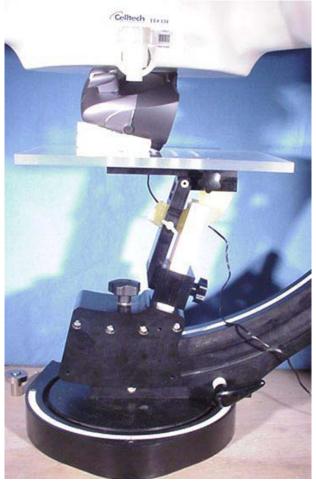


Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

BODY SAR TEST SETUP PHOTOGRAPHS

CS55 Base - Front Side of DUT (Left Side Tilted - Left Side Internal Antenna) - Touch Position





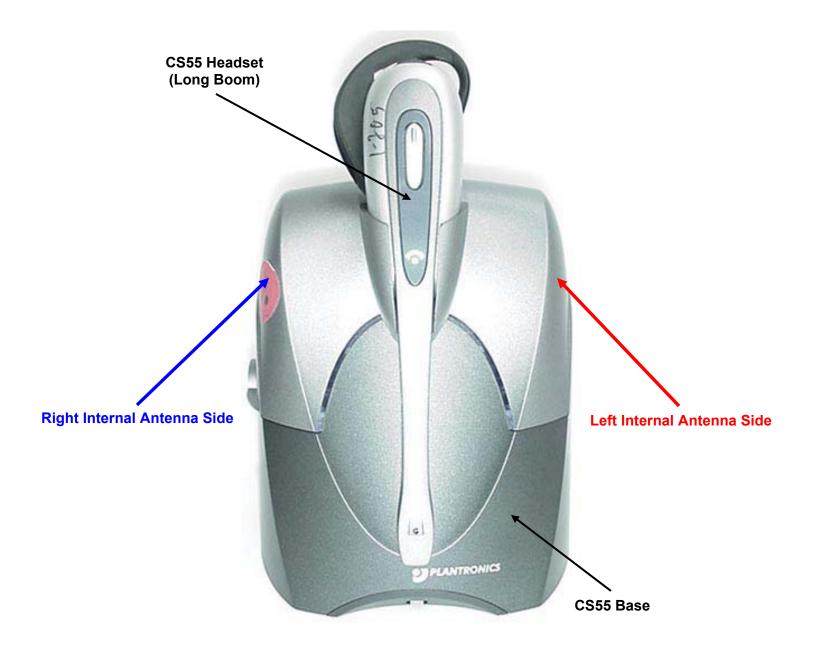




Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headse	PLANTRONICS.	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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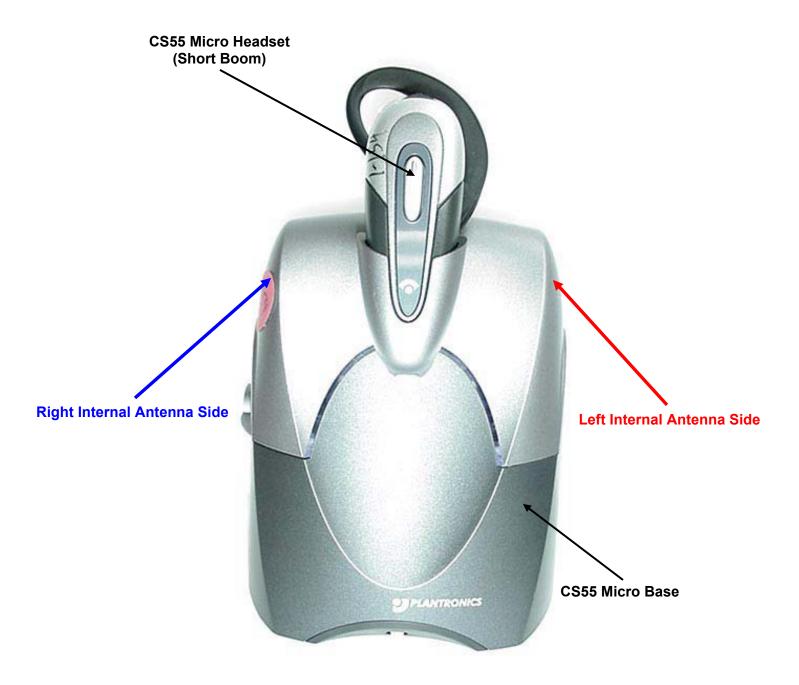
Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102



Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		PLANTRONICS.
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

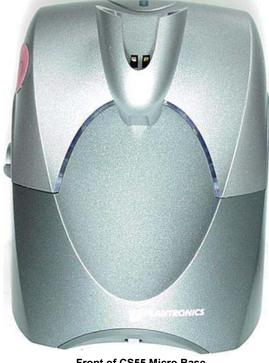


Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		PLANTRONICS.
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102





Front of CS55 Base

Front of CS55 Micro Base

The two bases are identical expect for the charge cradle.



Back of CS55 Base / CS55 Micro Base

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		PLANTRONICS.
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102



CSS55 Base - Left Side



CS55 Micro Base - Right Side

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		■ PLANTRONICS.
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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Test Report Serial No.:	072605AL8-F6	59-S15B	Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005	Test Rep	ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102



DUT with AC Power Adapter



Test Report Serial No.:	072605AL8-F659-S15B		Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005 Test Repo		ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

APPENDIX E - SYSTEM VALIDATION

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		PLANTRONICS.
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range:	1921.536 - 1928.448 MHz	
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1900 MHz SYSTEM VALIDATION DIPOLE

Туре:	1900 MHz Validation Dipole	
Asset Number:	00032	
Serial Number:	151	
Place of Calibration:	Celltech Labs Inc.	
Date of Calibration:	June 17, 2005	
Celltech Labs Inc. hereby certifies that this devi	ice has been calibrated on the date indicated al	bove
Calibrated by:	Sum James	
Approved by:	Spencer Watson	



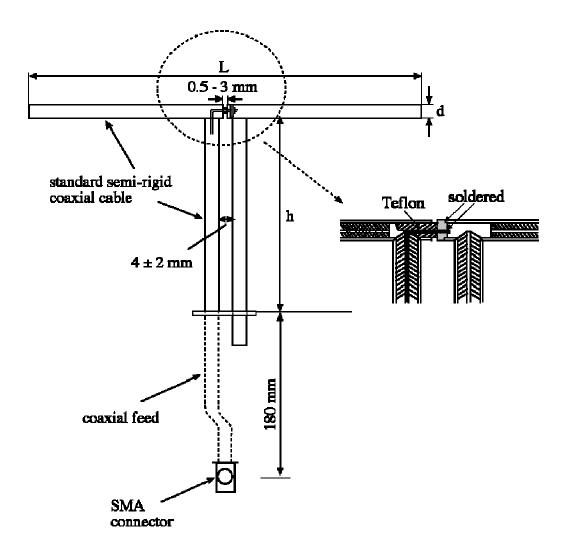
1. Dipole Construction & Electrical Characteristics

The validation dipole was constructed in accordance with the IEEE Standard "Annex G (informative) Reference dipoles for use in system validation". The electrical properties were measured using an HP 8753ET Network Analyzer. The network analyzer was calibrated to the validation dipole N-type connector feed point using an HP85032E Type N calibration kit. The dipole was placed parallel to a planar phantom at a separation distance of 10.0mm from the simulating fluid using a loss-less dielectric spacer. The measured input impedance is:

Feed point impedance at 1900MHz $Re{Z} = 47.803\Omega$

 $Im{Z} = 6.4002\Omega$

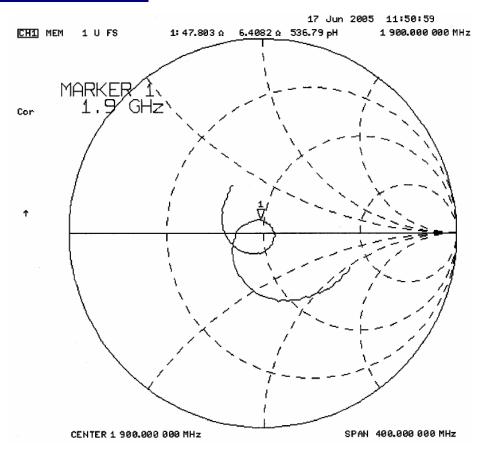
Return Loss at 1900MHz -23.205dB

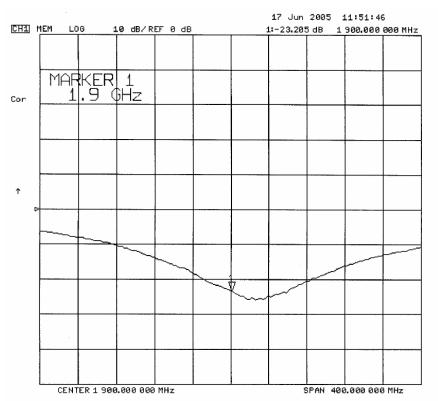


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2. Validation Dipole VSWR Data





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3. Validation Dipole Dimensions

Frequency (MHz)	L (mm)	h (mm)	d (mm)
300	420.0	250.0	6.2
450	288.0	167.0	6.2
835	161.0	89.8	3.6
900	149.0	83.3	3.6
1450	89.1	51.7	3.6
1800	72.0	41.7	3.6
1900	68.0	39.5	3.6
2000	64.5	37.5	3.6
2450	51.8	30.6	3.6
3000	41.5	25.0	3.6

4. Validation Phantom

The validation phantom is the SAM (Specific Anthropomorphic Mannequin) phantom manufactured by Schmid & Partner Engineering AG. The SAM phantom is a Fiberglass shell integrated in a wooden table. The shape of the shell corresponds to the phantom defined by SCC34-SC2. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents evaporation of the liquid. Reference markings on the phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

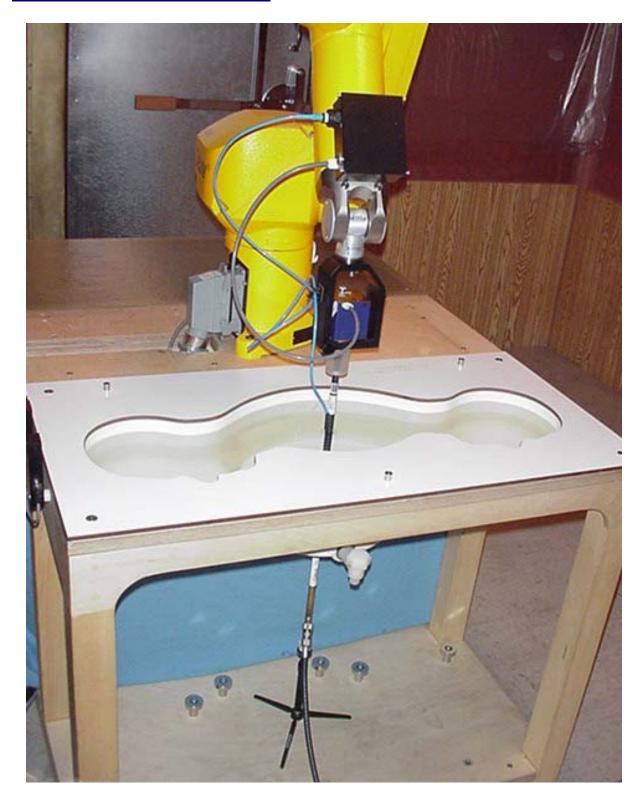
Shell Thickness: $2.0 \pm 0.1 \text{ mm}$ Filling Volume: Approx. 25 liters

Dimensions: 50 cm (W) x 100 cm (L)

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5. 1900 MHz System Validation Setup



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1900 MHz System Validation Setup



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6. Measurement Conditions

The SAM phantom was filled with 1900 MHz brain simulating tissue.

Relative Permittivity: 38.4

Conductivity: 1.40 mho/m

Ambient Temperature: 23.4 °C

Fluid Temperature: 22.7 °C

Fluid Depth: \geq 15.0 cm

Barometric Pressure: 100.6 kPa

Humidity: 35%

The 1900 MHz tissue simulant consists of the following ingredients:

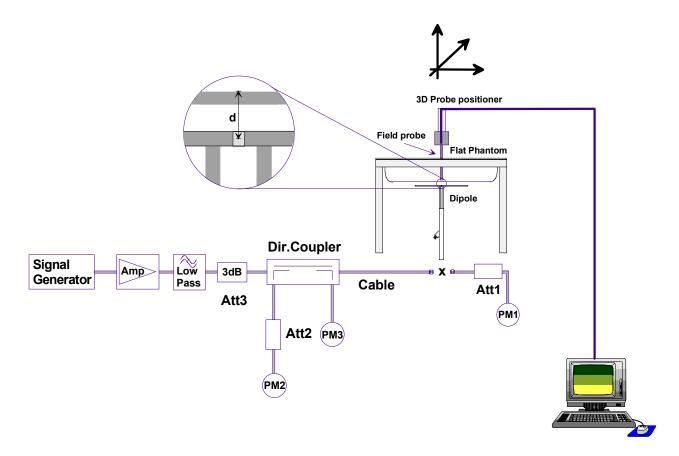
Ingredient	Percentage by weight
Water	55.85%
Glycol	44.00%
Salt	0.15%
Target Dielectric Parameters at 22 °C	$\epsilon_{\rm r}$ = 40.0 σ = 1.40 S/m

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7. SAR Measurement

The SAR measurement was performed with the E-field probe in mechanical detection mode only. The setup and determination of the forward power into the dipole was performed using the following procedures.



First the power meter PM1 (including attenuator Att1) is connected to the cable to measure the forward power at the location of the dipole connector (X). The signal generator is adjusted for the desired forward power at the dipole connector (taking into account the attenuation of Att1) as read by power meter PM2. After connecting the cable to the dipole, the signal generator is readjusted for the same reading at power meter PM2. If the signal generator does not allow adjustment in 0.01dB steps, the remaining difference at PM2 must be taken into consideration. PM3 records the reflected power from the dipole to ensure that the value is not changed from the previous value. The reflected power should be 50dB below the forward power.

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8. Validation Dipole SAR Test Results

Ten SAR measurements were performed in order to achieve repeatability and to establish an average target value.

Validation Measurement	SAR @ 0.25W Input averaged over 1g	SAR @ 1W Input averaged over 1g	SAR @ 0.25W Input averaged over 10g	SAR @ 1W Input averaged over 10g	Peak SAR @ 0.25W Input
Test 1	9.97	39.88	5.20	20.80	17.7
Test 2	10.0	40.00	5.19	20.76	17.9
Test 3	10.1	40.40	5.21	20.84	18.1
Test 4	9.98	39.92	5.20	20.80	17.8
Test 5	9.96	39.84	5.19	20.76	17.7
Test 6	9.99	39.96	5.18	20.72	17.9
Test 7	9.89	39.56	5.16	20.64	17.5
Test 8	9.95	39.80	5.19	20.76	17.6
Test 9	9.96	39.84	5.20	20.80	17.6
Test 10	9.92	39.68	5.19	20.76	17.5
Average	9.972	39.888	5.191	20.764	17.73

The results have been normalized to 1W (forward power) into the dipole.

1g/10g Averaged	Average Measured SAR @ 1W Input	IEEE Target SAR @ 1W Input	Deviation (%)
1 gram	39.888	39.7	+ 0.474
10 gram 20.764		20.5	+ 1.29

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1900 MHz System Validation - June 17, 2005

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: 151

Ambient Temp: 23.4 °C; Fluid Temp: 22.7 °C; Barometric Pressure: 100.6 kPa; Humidity: 35%

Communication System: CW

Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL1900 (σ = 1.40 mho/m; ε_r = 38.4; ρ = 1000 kg/m³)

- Probe: ET3DV6 SN1590; ConvF(5.44, 5.44, 5.44); Calibrated: 20/05/2005
- Sensor-Surface: 4mm (Mechanical And Optical Surface Detection)
- Electronics: DAE3 Sn370; Calibrated: 25/01/2005
- Phantom: SAM 4.0; Type: Fiberglas; Serial: 1033
- Measurement SW: DASY4, V4.5 Build 19; Postprocessing SW: SEMCAD, V1.8 Build 146

1900 MHz System Validation/Area Scan (5x8x1): Measurement grid: dx=15mm, dy=15mm

1900 MHz System Validation/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 94.6 V/m; Power Drift = -0.018 dB

Peak SAR (extrapolated) = 17.7 W/kg

SAR(1 g) = 9.97 mW/g; SAR(10 g) = 5.20 mW/g

1900 MHz System Validation/Zoom Scan 2 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 93.6 V/m; Power Drift = -0.025 dB

Peak SAR (extrapolated) = 17.9 W/kg

SAR(1 g) = 10.0 mW/g; SAR(10 g) = 5.19 mW/g

1900 MHz System Validation/Zoom Scan 3 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 94.1 V/m; Power Drift = -0.011 dB

Peak SAR (extrapolated) = 18.1 W/kg

SAR(1 g) = 10.1 mW/g; SAR(10 g) = 5.21 mW/g

1900 MHz System Validation/Zoom Scan 4 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 94.8 V/m; Power Drift = 0.00 dB

Peak SAR (extrapolated) = 17.8 W/kg

SAR(1 g) = 9.98 mW/g; SAR(10 g) = 5.20 mW/g

1900 MHz System Validation/Zoom Scan 5 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 94.8 V/m; Power Drift = -0.01 dB

Peak SAR (extrapolated) = 17.7 W/kg

SAR(1 g) = 9.96 mW/g; SAR(10 g) = 5.19 mW/g

1900 MHz System Validation/Zoom Scan 6 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 95.6 V/m; Power Drift = -0.081 dB

Peak SAR (extrapolated) = 17.9 W/kg

SAR(1 g) = 9.99 mW/g; SAR(10 g) = 5.18 mW/g

1900 MHz System Validation/Zoom Scan 7 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 94.6 V/m; Power Drift = -0.019 dB

Peak SAR (extrapolated) = 17.5 W/kg

SAR(1 g) = 9.89 mW/g; SAR(10 g) = 5.16 mW/g

1900 MHz System Validation/Zoom Scan 8 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 95.0 V/m; Power Drift = -0.016 dB

Peak SAR (extrapolated) = 17.6 W/kg

SAR(1 g) = 9.95 mW/g; SAR(10 g) = 5.19 mW/g

1900 MHz System Validation/Zoom Scan 9 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 95.0 V/m; Power Drift = 0.00 dB

Peak SAR (extrapolated) = 17.6 W/kg

SAR(1 g) = 9.96 mW/g; SAR(10 g) = 5.20 mW/g

1900 MHz System Validation/Zoom Scan 10 (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

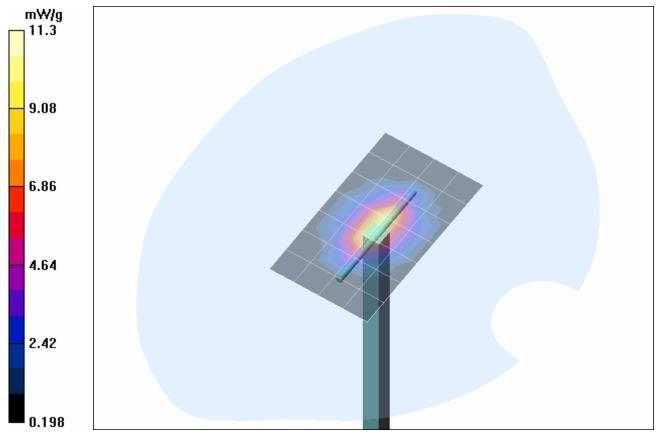
Reference Value = 94.7 V/m; Power Drift = -0.00 dB

Peak SAR (extrapolated) = 17.5 W/kg

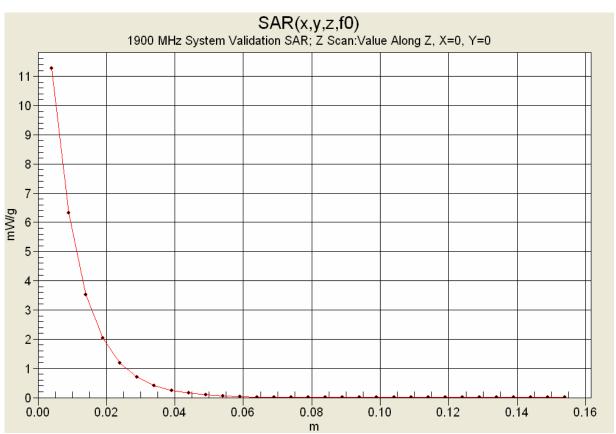
SAR(1 g) = 9.92 mW/g; SAR(10 g) = 5.19 mW/g

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1 g average of 10 measurements: 9.972 mW/g 10 g average of 10 measurements: 5.191 mW/g



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2.0000

System Validation - 1900 MHz Dipole (Brain) Celltech Labs Inc. Test Result for UIM Dielectric Parameter Fri 17/Jun/2005 Frequency (GHz) FreqFCC eH FCC OET 65 Supplement C (June 2001) Limits for Head Epsilon FCC_sH FCC OET 65 Supplement C (June 2001) Limits for Head Sigma Test_e Epsilon of UIM Test s Sigma of UIM ***************** FCC_eH FCC_sH Test_e Test_s 40.00 1.40 38.82 1.30 1.8000 40.00 1.40 38.66 1.32 1.8100 40.00 1.40 38.64 1.33 1.8200 40.00 1.40 38.60 1.33 1.8300 1.8400 40.00 1.40 38.57 1.34 40.00 1.8500 1.40 38.47 1.34 38.40 1.8600 40.00 1.40 1.36 1.8700 40.00 1.40 38.44 1.37 1.8800 40.00 1.40 38.34 1.38 1.8900 40.00 1.40 38.39 1.38 38.37 (1.40) 1.9000 40.00 1.40 1.40 1.9100 40.00 38.32 1.41 1.9200 40.00 1.40 38.34 1.42 1.9300 40.00 1.40 38.30 1.42 40.00 1.40 38.31 1.44 1.9400 1.9500 40.00 1.40 38.27 1.44 1.9600 40.00 1.40 38.20 1.46 1.9700 40.00 1.40 38.23 1.47 1.9800 40.00 1.40 38.11 1.49 1.9900 40.00 1.40 38.02 1.50

40.00 1.40 38.11

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1.52



Test Report Serial No.:	072605AL8-F659-S15B		Test Date:	Aug. 2, 2005
Date of Report Issue:	Aug. 11, 2005 Test Repo		ort Issue No.:	Issue 1 Rev 0
Description of Test:	RF Exposure	SAR	FCC 2.1093	IC RSS-102

APPENDIX G - SAM PHANTOM CERTIFICATE OF CONFORMITY

Applicant:	Plantronics Inc.	DUT Type:	Wireless Office Headset System - UPCS Base Unit		■ PLANTRONICS。	
Model(s):	CS55 Base, CS55	Micro Base	Tx Frequency Range: 1921.536 - 1928.448 MHz			
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Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland, Phone +41 1 245 97 00, Fax +41 1 245 97 79

Certificate of conformity / First Article Inspection

Item	SAM Twin Phantom V4.0			
Type No	QD 000 P40 BA			
Series No	TP-1002 and higher			
Manufacturer / Origin	Untersee Composites Hauptstr. 69 CH-8559 Fruthwilen Switzerland			

Tests

The series production process used allows the limitation to test of first articles. Complete tests were made on the pre-series Type No. QD 000 P40 AA, Serial No. TP-1001 and on the series first article Type No. QD 000 P40 BA, Serial No. TP-1006. Certain parameters have been retested using further series units (called samples).

Test	Requirement	Details	Units tested
Shape	Compliance with the geometry according to the CAD model.	IT'IS CAD File (*)	First article, Samples
Material thickness	Compliant with the requirements according to the standards	2mm +/- 0.2mm in specific areas	First article, Samples
Material parameters	Dielectric parameters for required frequencies	200 MHz – 3 GHz Relative permittivity < 5 Loss tangent < 0.05.	Material sample TP 104-5
Material resistivity	The material has been tested to be compatible with the liquids defined in the standards	Liquid type HSL 1800 and others according to the standard.	Pre-series, First article

Standards

- [1] CENELEC EN 50361
- [2] IEEE P1528-200x draft 6.5
- [3] IEC PT 62209 draft 0.9
- (*) The IT'IS CAD file is derived from [2] and is also within the tolerance requirements of the shapes of [1] and [3].

Conformity

Based on the sample tests above, we certify that this item is in compliance with the uncertainty requirements of SAR measurements specified in standard [1] and draft standards [2] and [3].

Date

18.11.2001

Signature / Stamp

Schmid & Partner Fin Boulott

Zeughausstrasse 43, CH-8004 Zurich Tel. +41 1 245 97 00, Fax +41 1 245 97 79